

Search Notes

Application/Control No.

10/527,760

Examiner

James A. Dudek

Applicant(s)/Patent under
Reexamination

MIYASHITA ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	73-74	10/10/2006	JAD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR